Applicant(s)/Patent Under Application/Control No. Reexamination 10/015,015 ANDERSON, ERIC **Notice of References Cited** Examiner Art Unit Page 1 of 1 2143 Kyung H Shin **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 715/513 09-2003 Sequeira, William J. US-6,620,205 705/10 01-2005 Liu et al. В US-6,839,680 380/239 12-2004 Marconcini et al. С US-6,834,110 709/238 11-2004 Grove et al. US-6,820,133 D Ε US-F US-US-G US-Н 1 US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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